

Search Notes

Application No.

10/768,662

Examiner

John T. Kwon

Applicant(s)

ABE ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	672		
701	109		
	114		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR